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TEST REPORT

Application No.:	SZEM1703001720CR
Applicant: Address of Applicant:	Flashbay Electronics Blgd b & C Xi Feng Cheng IND Zone, No.2 FuYuan Road He Ping, Village, FuYong Town, ShenZhen
Manufacturer:	Flashbay Electronics
Address of Manufacturer:	Blgd b & C Xi Feng Cheng IND Zone, No.2 FuYuan Road, He Ping Village, FuYong Town, ShenZhen
Factory:	Flashbay Electronics
Address of Factory:	Blgd b & C Xi Feng Cheng IND Zone, No.2 FuYuan Road He Ping, Village, FuYong Town, ShenZhen
Equipment Under Test (EU1	ī):
EUT Name:	Bluetooth Headphone
Model No.:	ARC
Standards:	AS/NZS CISPR 32:2013
Date of Receipt:	2017-03-16
Date of Test:	2017-03-22 to 2017-04-05
Date of Issue:	2017-04-11
Test Result :	Pass*

* In the configuration tested, the EUT complied with the standards specified above.



Jack Zhang EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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Revision Record							
Version	/ersion Chapter Date Modifier Remark						
01		2017-04-11		Original			

Authorized for issue by:		
Tested By	feter Genej	2017-04-05
	Peter Geng /Project Engineer	Date
Checked By	Eric Fu	2017-04-11
	Eric Fu /Reviewer	Date



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2 Test Summary

Emission Part					
Item	Standard	Method	Requirement	Result	
Radiated Disturbance (30MHz-1GHz)	AS/NZS CISPR 32:2013	AS/NZS CISPR 32:2013	Class B	Pass	
Conducted Disturbance at Mains Terminals (150kHz-30MHz)	AS/NZS CISPR 32:2013	AS/NZS CISPR 32:2013	Class B	Pass	

InternalSource	UpperFrequency	
Below 108MHz	1GHz	
108MHz to 500MHz 2GHz		
500MHz to 1GHz	5GHz	
Above 1GHz	5 times the highest frequency or 6 GHz, whichever is less	



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4 General Information

4.1 Details of E.U.T.

Internal source

Power supply:	DC 3.7V rechargeable battery
Test voltage	AC 230V/50Hz
Cable:	AUX IN line: 120cm, unshielded
	USB charging line: 80cm, unshielded

16MHz

4.2 Description of Support Units

Description Manufacturer		Model No.	Serial No.	
iPhone 4	Apple	A1349	C37HL4GXDP0N	
Adapter	Apple	A1357 W010A051	REF. No.SEA0500	

4.3 Measurement Uncertainty

No.	ltem	Measurement Uncertainty
1	Conduction emission 3.0dB (150kHz to 30MHz)	
2	Radiated emission	4.5dB (30MHz-1GHz)
3	Temperature test	1 ℃
4	4 Humidity test 3%	



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4.4 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594 No tests were sub-contracted.

4.5 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

• VCCI

The 10m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

FCC – Registration No.: 556682

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.: 556682.

Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

4.6 Deviation from Standards

None

4.7 Abnormalities from Standard Conditions

None

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5 Equipment List

Radiated Disturbance(30MHz-1GHz	<u>z)</u>
---------------------------------	-----------

Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
10m Semi-Anechoic Chamber	SAEMC	FSAC1018	SEM001-03	2016-05-13	2017-05-13
EMI Test Receiver (9k-3GHz)	Rohde & Schwarz	ESR	SEM004-03	2016-04-25	2017-04-25
Trilog-Broadband Antenna (30M-1GHz)	Schwarzbeck	VULB9168	SEM003-18	2016-06-29	2019-06-29
Pre-amplifier	Sonoma Instrument Co	310N	SEM005-03	2016-07-06	2017-07-06

Conducted Disturbance at Mains Terminals(150kHz-30MHz)									
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date				
Shielding Room	Shielding Room ChangZhou ZhongYu		SEM001-06	2016-05-13	2017-05-13				
LISN	Rohde & Schwarz	ENV216	SEM007-01	2016-10-09	2017-10-09				
LISN	ETS-LINDGREN	3816/2	SEM007-02	2016-04-25	2017-04-25				
EMI Test Receiver	Rohde & Schwarz	ESCI	SEM004-02	2016-04-25	2017-04-25				

General used equipment								
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date			
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-03	2016-10-12	2017-10-12			
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-04	2016-10-12	2017-10-12			
Humidity/ Temperature Indicator	Mingle	N/A	SEM002-08	2016-10-12	2017-10-12			
Barometer	Changchun Meteorological Industry Factory	DYM3	SEM002-01	2016-05-18	2017-05-18			



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6 Emission Test Results

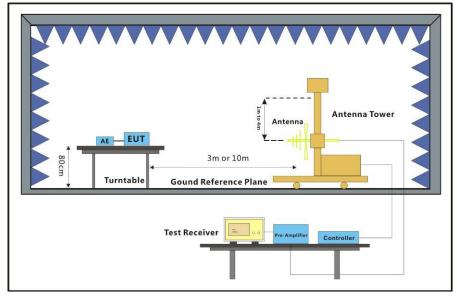
6.1 Radiated Disturbance(30MHz-1GHz)

Test Requirement:	AS/NZS CISPR 32:2013
Test Method:	AS/NZS CISPR 32:2013
Frequency Range:	30MHz to 1GHz
Measurement Distance:	10m
Limit:	
30MHz-230MHz	30 dB(µV/m) quasi-peak
230MHz-1GHz	37 dB(µV/m) quasi-peak
Detector:	Peak for pre-scan (120kHz resolution bandwidth) 30M to 1000MHz

6.1.1 E.U.T. Operation

Operating Enviror	nment:							
Temperature:	24.0 °C	Humidity:	54 % RH	Atmospheric Pressure:	1015 mbar			
Pretest these mode to find the worst case:	c:AUX Input_S d: Charging m		Sine Wave					
The worst case for final test:	d: Charging mode							

6.1.2 Test Setup Diagram



6.1.3 Measurement Data

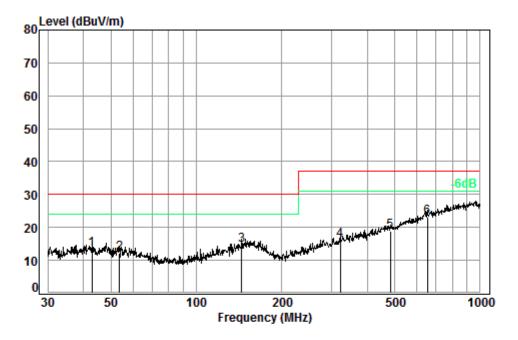
An initial pre-scan was performed in the chamber using the spectrum analyser in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by BiConiLog antenna with 2 orthogonal polarities.

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Mode:d; Polarization:Horizontal



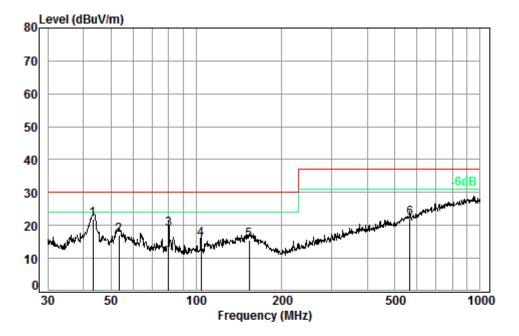
Condition: 10m HORIZONTAL Job No. : 01720CR Test Mode: d

	Freq			Preamp Factor				
	MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
1	42.90	6.80	13.07	32.99	26.46	13.34	30.00	-16.66
2	53.69	6.97	12.48	32.98	25.75	12.22	30.00	-17.78
3	144.84	7.43	13.08	32.75	26.69	14.45	30.00	-15.55
4	322.19	8.11	13.29	32.60	27.18	15.98	37.00	-21.02
5 6 p;	483.91 p 651.94			32.60 32.60				



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Mode:d; Polarization:Vertical



Condition: 10m VERTICAL Job No. : 01720CR Test Mode: d

				Preamp Factor				Over Limit
	MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
2 3 4 10 5 1	43.35 53.51 79.80 04.17 53.74 66.62	6.97 7.10 7.22 7.47	12.49 8.57 9.81 13.40	32.99 32.98 32.87 32.79 32.74 32.60	30.57 36.04 31.63 27.37	17.05 18.84 15.87 15.50	30.00 30.00 30.00 30.00	-12.95 -11.16 -14.13 -14.50



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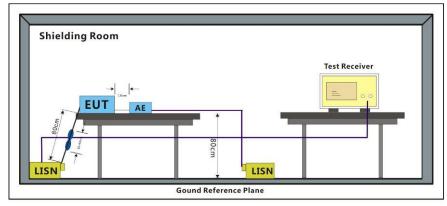
6.2 Conducted Disturbance at Mains Terminals(150kHz-30MHz)

Test Requirement:	AS/NZS CISPR 32:2013
Test Method:	AS/NZS CISPR 32:2013
Frequency Range:	150kHz to 30MHz
Limit:	
0.15M-0.5MHz	66dB(μ V)-56dB(μ V) quasi-peak, 56dB(μ V)-46dB(μ V) average
0.5M-5MHz	56dB(μV) quasi-peak, 46dB(μV) average
5M-30MHz	$60dB(\mu V)$ quasi-peak, $50dB(\mu V)$ average
Detector:	Peak for pre-scan (9kHz resolution bandwidth) 0.15M to 30MHz

6.2.1 E.U.T. Operation

Operating Enviro	nment:					
Temperature:	25.0 °C	Humidity:	55 % RH	Atmospheric Pressure:	1015	mbar
Test mode:	d: Charging m	ode				

6.2.2 Test Setup Diagram

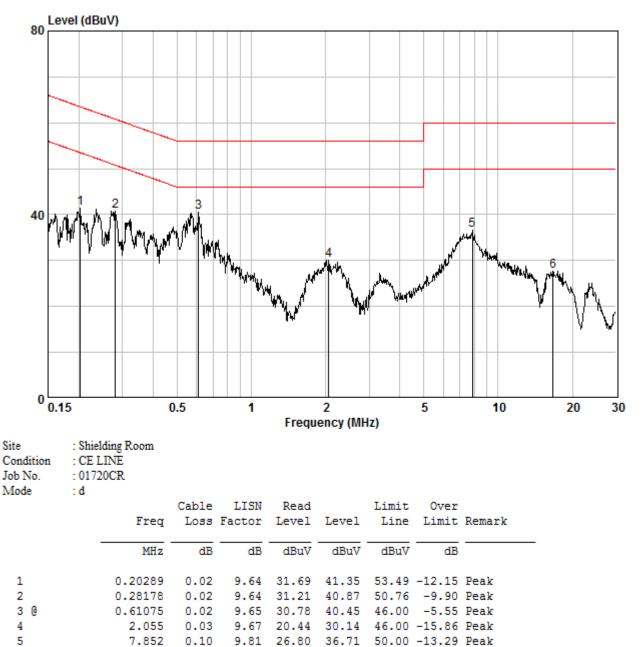


6.2.3 Measurement Data

An initial pre-scan was performed with peak detector.Quasi-Peak or Average measurement were performed at the frequencies with maximized peak emission were detected.



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Mode:d; Line:Live Line

16.661

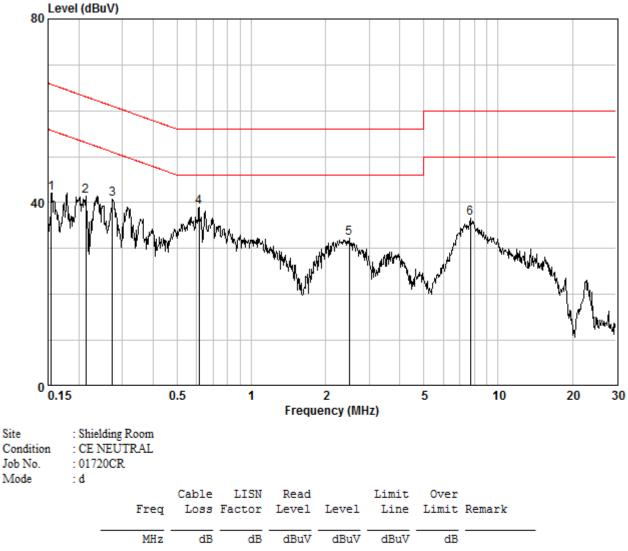
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0.16 10.03 17.57 27.76 50.00 -22.24 Peak



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Mode:d; Line:Neutral Line

	Freq		LISN Factor			Limit Line		Remark
	MHz	dB	dB	dBuV	dBuV	dBuV	dB	
1	0.15485	0.02	9.64	32.43	42.09	55.74	-13.65	Peak
2	0.21392	0.02	9.63	31.83	41.48	53.05	-11.57	Peak
3	0.27297	0.02	9.63	31.01	40.66	51.03	-10.37	Peak
4	0.61400	0.02	9.63	29.34	38.99	46.00	-7.01	Peak
5	2.487	0.03	9.66	22.59	32.28	46.00	-13.72	Peak
6	7.728	0.10	9.79	26.65	36.53	50.00	-13.47	Peak



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7 Photographs



7.1 Radiated Disturbance(30MHz-1GHz) Test Setup

7.2 Conducted Disturbance at Mains Terminals(150kHz-30MHz) Test Setup





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7.3 EUT Constructional Details

Refer to Appendix A - Photographs of EUT Constructional Details for SZEM1703001720CR.